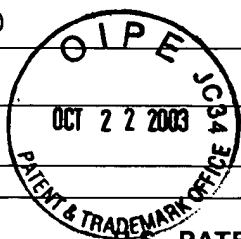


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Atty. Docket No.: 06502.0054-01000	Application No.: 015,801/10	RECEIVED
Applicant:		OCT 28 2003
Filing Date: December 17, 2001	Group 2153	Technology Center 2100



U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Date	Name	Class	Sub Class	Filing Date If Appropriate
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Examiner <i>IR Fletch</i>	Date Considered: <i>10-24-03</i>
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Atty. Docket No.: 06502.0054-1000 Applicant: Ann M. WOLLRATH et al. Filing Date: December 17, 2001		Application No.: 10/015,801 AUG 28 2003 Group: 2172 Technology Center 2100	
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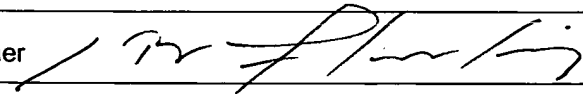
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JRF	US5,303,042	4/12/1994	Lewis et al.	348	14.01	3/25/1992
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